

IGBT/SiC Diode Co-pack

Features

- Optimal Punch Through (OPT) technology
- SiC freewheeling diode
- · Positive temperature coefficient for easy paralleling
- Extremely fast switching speeds
- Temperature independent switching behavior of SiC rectifier
- · Best RBSOA/SCSOA capability in the industry
- · High junction temperature
- · Industry standard packaging

GB100XCP12-227

V _{CES}	=	1200 V
I _{см}	=	100 A
	=	1.9 V

Package

• RoHS Compliant



SOT - 227

Advantages

- Industry's highest switching speeds
- High temperature operation
- Improved circuit efficiency
- · Low switching losses

Applications

- Solar Inverters
- Aerospace Actuators
- Server Power Supplies
- Resonant Inverters > 100 kHz
- Inductive Heating
- Electronic Welders

Maximum Ratings at T_j = 175 °C, unless otherwise specified

Parameter	Symbol	Conditions		Values		Unit
IGBT						
Collector-Emitter Voltage	V _{CES}			1200		V
DC-Collector Current	lc	T _C ≤ 130 °C		100		А
Peak Collector Current	I _{CM}	Limited by T _{vjmax}		200		А
Gate Emitter Peak Voltage	V_{GES}			± 20		V
IGBT Short Circuit SOA	t _{psc}	V_{CC} = 900 V, $V_{CEM} \le 1200$ V $V_{GE} \le 15$ V, $Tv_j \le 125$ °C	10			μs
Operating Temperature	T _{vi}		-	40 to +17	5	°C
Storage Temperature	T _{stg}		-	40 to +17	5	°C
Isolation Voltage	VISOL	I _{SOL} < 1 mA, 50/60 Hz, t = 1 s		3000		V
Free-wheeling Silicon Carbide diode						
DC-Forward Current	l _F	T _C ≤ 130 °C		100		А
Non Repetitive Peak Forward Current	I _{FM}	T _C = 25 °C, t _P = 10 μs		tbd		А
Surge Non Repetitive Forward Current	I _{F,SM}	t_P = 10 ms, half sine, T_c = 25 °C		tbd		А
Thermal Characteristics						
Thermal resistance, junction - case	R _{thJC}	IGBT	0.08		°C/W	
Thermal resistance, junction - case	R_{thJC}	SiC Diode		0.53		°C/W
			Values			
Mechanical Properties			min.	typ.	max.	
Mounting Torque	M _d			1.5		Nm
Terminal Connection Torque			1.3		1.5	Nm
Weight				29		g
Case Color				Black		
Dimensions			38	3 x 25.4 x	12	mm



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Electrical Characteristics at T_j = 175 °C, unless otherwise specified

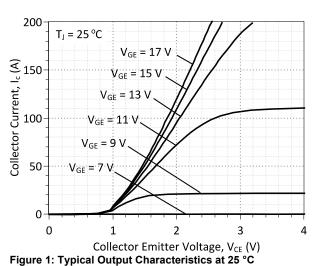
Parameter	Symbol	Symbol Conditions -		Values			
Falailletei	Symbol	Conditions	min.	typ.	max.	Unit	
IGBT							
Gate Threshold Voltage	V _{GE(th)}	V _{GE} = V _{CE} , I _C = 4 mA, T _j = 25 °C	5	6.2	7	V	
Collector-Emitter Leakage Current	I _{CES,25}	V _{GE} = 0 V, V _{CE} = V _{CES} , T _j = 25 °C		0.10	1	mA	
	I _{CES,175}	V _{GE} = 0 V, V _{CE} = V _{CES} , T _j = 175 °C		3.15		mA	
Gate-Leakage Current	I _{GES}	V _{CE} = 0 V, V _{GE} = 20 V, T _j = 175 °C	-400		400	nA	
Collector-Emitter Threshold Voltage	V _{CE(TO)}	T _j = 25°C		1.1		V	
Collector Emitter Slope Desistance	R _{CE,25}	V _{GE} = 15 V, T _j = 25 °C		7.9		mΩ	
Collector-Emitter Slope Resistance	R _{CE,175}	V _{GE} = 15 V, T _j = 175 °C		11.4		mΩ	
Collector-Emitter Saturation Voltage	$V_{CE(SAT)}$	I _C = 100 A, V _{GE} = 15 V, T _i = 25 °C (175 °C)		1.9 (2.2)		V	
nput Capacitance	C _{ies}	(0)(-)(25)(25)(25)(25)(8.55		nF	
Output Capacitance	C _{oes}	− V _{GE} = 0 V, V _{CE} = 25 V, f = 1 MHz, T _i = 150 °C		1.39		nF	
Reverse Transfer Capacitance	C _{res}	1 – 1 Win2, 1j – 130 C		0.25		nF	
nternal Gate Resistance	R _{Gint}			2		Ω	
Gate Charge	Q_G	V _{CC} = 750 V, I _C = 100 A, V _{GE} = -815 V, T _I = 25 °C (125 °C)		900 (900)		nC	
Module Lead Resistance	R _{mod}	T _c = 25 °C (175 °C)		tbd		mΩ	
Reverse Bias Safe Operating Area	RBSOA	T _j =175 °C, R _g =56Ω, V _{CC} =1200 V, V _{GE} =15 V		150		А	
Short Circuit Current	I _{sc}	$T_i = 175 \text{ °C}, R_g = 56\Omega, V_{CC} = 900 \text{ V},$		470		А	
Short Circuit Duration	t _{sc}	V _{GE} = ±15 V			10	μs	
Rise Time	tr			254		ns	
Fall Time	t _f	V _{cc} = 800 V, I _c = 100 A,		153		ns	
Turn On Delay Time	t _{d(on)}	$R_{aon} = R_{aoff} = 10 \Omega,$		244		ns	
Turn Off Delay Time	t _{d(off)}	V _{GE(on)} = 15 V, V _{GE(off)} = -8 V,		488		ns	
Turn-On Energy Loss Per Pulse	Eon	L _s = 0.8 μH, Τ _j = 25 °C		14.2		mJ	
Turn-Off Energy Loss Per Pulse	E _{off}	7		15.7		mJ	
Rise Time	tr			211		ns	
Fall Time	t _f	V _{cc} = 800 V, I _c = 100 A,		172		ns	
Turn On Delay Time	t _{d(on)}	$R_{gon} = R_{goff} = 10 \ \Omega,$		240		ns	
Turn Off Delay Time	t _{d(off)}	$_{VGE(on)}$ = 15 V, $V_{GE(off)}$ = -8 V,		636		ns	
Turn-On Energy Loss Per Pulse	Eon	L _S = 0.8 μH, T _j = 175 °C		11.1		mJ	
Turn-Off Energy Loss Per Pulse	E _{off}			21.8		mJ	

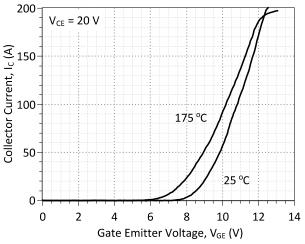
Free-wheeling Silicon Carbide Diode

Forward Voltage	V _F	I _F = 100 A, V _{GE} = 0 V, T _j = 25 °C (175 °C)	2.08 (3.5)	V
Threshold Voltage at Diode	V _{D(TO)}	$T_j = 25 \text{ °C}$	0.8	V
Peak Reverse Recovery Current	Irrm	I _F = 100 A, V _{GE} = 0 V, V _R = 800 V,	10	А
Reverse Recovery Time	t _{rr}	-dI _F /dt = 625 A/µs, T _j = 175 °C	100	ns
Rise Time	t _r	V _{cc} = 800 V, I _c = 100 A,	148	ns
Fall Time	t _f	$R_{gon} = R_{goff} = 10 \Omega,$	336	ns
Turn-On Energy Loss Per Pulse	Eon	_{VGE(on)} = 15 V, V _{GE(off)} = -8 V,	218	μJ
Turn-Off Energy Loss Per Pulse	E _{off}	L _s = 0.8 μH, Τ _j = 25 °C	113	μJ
Reverse Recovery Charge	Qrr		730	nC
Rise Time	tr		178	ns
Fall Time	t _f	$\begin{array}{c} V_{CC} = 800 \ V, \ I_C = 100 \ A, \\ R_{gon} = R_{gorf} = 10 \ \Omega, \\ v_{GE(on)} = 15 \ V, \ V_{GE(off)} = -8 \ V, \\ L_S = 0.8 \ \mu\text{H}, \ T_j = 175 \ ^{\circ}\text{C} \end{array}$	268	ns
Turn-On Energy Loss Per Pulse	Eon		23	μJ
Turn-Off Energy Loss Per Pulse	E _{off}		334	μJ
Reverse Recovery Charge	Q _{rr}		480	nC

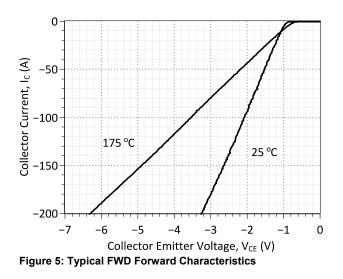


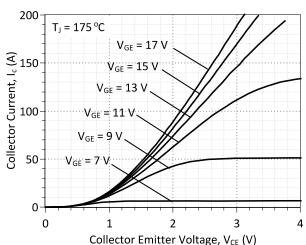
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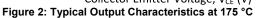


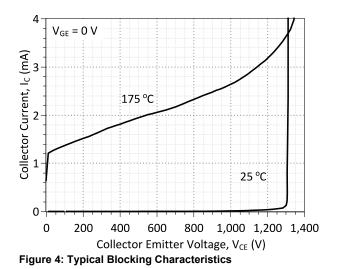


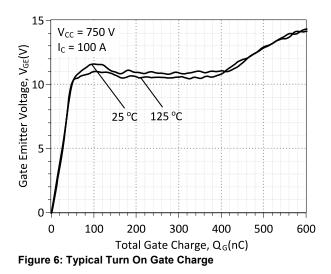




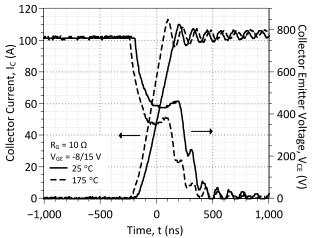








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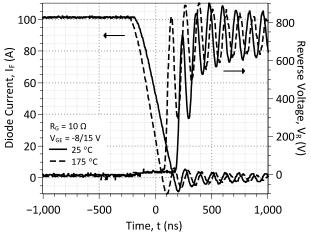
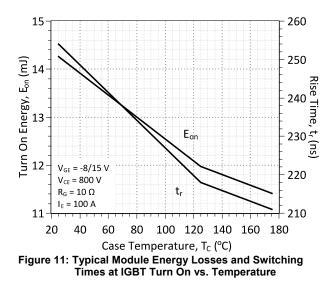


Figure 9: Typical Hard-Switched Free-wheeling SiC Diode Turn Off Waveforms



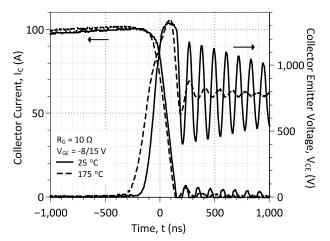


Figure 8: Typical Hard-Switched IGBT Turn Off Waveforms

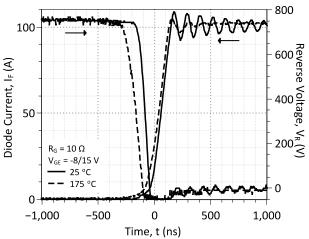
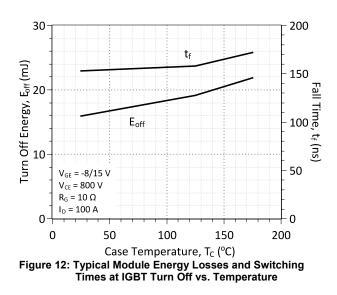
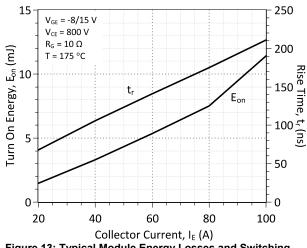
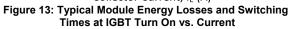


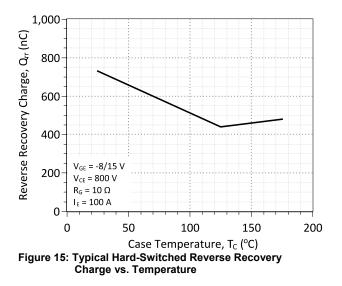
Figure 10: Typical Hard-Switched Free-wheeling SiC Diode Turn On Waveforms

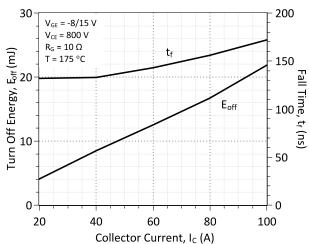


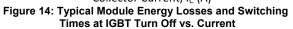
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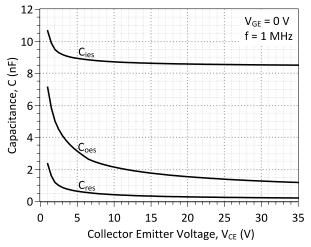
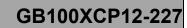


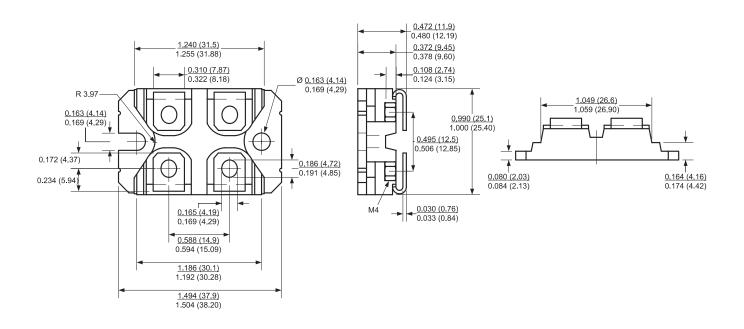
Figure 16: Typical C-V Characteristics



Package Dimensions:

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PACKAGE OUTLINE



NOTE

1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.

2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS

Revision History						
Date	Revision	Comments	Supersedes			
2013/02/08	2	Updated Electrical Characteristics				
2012/07/30	1	Second generation release	GA100XCP12-227			
2011/01/06	0	Initial release				

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